

Notice of References Cited

Application/Control No.

10/027,145

Applicant(s)/Patent Under
Reexamination
LAUKKANEN ET AL.

Examiner

Ismael Quiñones

Art Unit

2686

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,674,372 B1	01-2004	Ouyang, Yen I	341/28
	B	US-6,631,501 B1	10-2003	Jurion et al.	715/535
	C	US-5,852,783 A	12-1998	Tabe et al.	455/566
	D	US-6,356,258 B1	03-2002	Kato et al.	345/168
	E	US-6,007,339 A	12-1999	Zen et al.	434/157
	F	US-6,007,339 A	12-1999	Zen et al.	434/157
	G	US-6,636,163 B1	10-2003	Hsieh, Hsien-Fen	341/28
	H	US-6,686,852 B1	02-2004	Guo, Jin	341/22
	I	US-2003/0190181 A1	10-2003	Kim, Min Kyum	400/472
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.